

**Search Notes**

Application/Control No.

10/560,229

Examiner

JOHN J. LEE

Applicant(s)/Patent under  
Reexamination

KIKKOJI ET AL.

Art Unit

2618

**SEARCHED**

Class	Subclass	Date	Examiner
455	3.01-05 414.1-4 186.1,7 550.1	11/7/2008	J.L
455	150.1	11/7/2008	J.L
455	188.1	11/7/2008	J.L
455	151.1	11/7/2008	J.L
455	154.1	11/7/2008	J.L
455	179.1	11/7/2008	J.L
725	63	11/7/2008	J.L
386	95	11/7/2008	J.L

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
<b>455</b>	<b>3.01-05</b>	<b>11/9/2008</b>	<b>J.L</b>
455	414.1-4	11/9/2008	J.L
455	186.1	11/9/2008	J.L
Interference and Inventor Search		11/9/2008	J.L

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	11/7/2008	J.L